


<b>Search Notes</b>  	<b>Application/Control No.</b>  10625334	<b>Applicant(s)/Patent Under Reexamination</b>  MEIROWITZ, DIANE R.
	<b>Examiner</b>  Tecklu, Isaac T	<b>Art Unit</b>  2192

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
717/140, 717/148, 717/154, 717/155, 717/156	05/09/2007	IT
Searched EAST all database	05/09/2007	IT
NPL (ACM, IEEE/Xplore)	05/09/2007	IT
Google	05/09/2007	IT
Consulted With SPE Tuan Q. Dam	05/0/20077	IT

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
717	140, 148, 154 and 155	05/09/2007	IT